

Notice of References Cited

Application/Control No.

09/744,552

Applicant(s)/Patent Under
Reexamination
HEUER ET AL.

Examiner

Allen Wong

Art Unit

2613

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,278,736	08-2001	De Haan et al.	375/240.16
	B	US-5,657,087	08-1997	Jeong et al.	375/240.16
	C	US-5,734,737	03-1998	Chang et al.	382/107
	D	US-6,018,368	01-2000	Kim et al.	375/240.24
	E	US-5,764,803	06-1998	Jacquin et al.	382/236
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 689 359 A2	12-1995	EPO	Jeong et al.	H04N 7/50
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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